

Search Notes

Application/Control No.

09/883,178

Examiner

Mark K. Han

Applicant(s)/Patent under
Reexamination

NAIMARK ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	5.01	5/12/2006	mlh
	6.09		
	27		
	29		
	35		
	43		
	44		
	48		
	93.01		
	181		
	187		
	190		
	264		
	272		
	523		
	890.1		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor name search	6/27/2005	mlh
EAST text search	5/12/2006	mlh